

Parameter		Symbol	Тур	Max	Units	
Maximum Junction-to-Ambient <sup>A</sup>	t ≤ 10s	$R_{ ext{ heta}JA}$	31	40	°C/W	
Maximum Junction-to-Ambient AD	Steady State	IN <sub>θ</sub> JA	59	75	°C/W	
Maximum Junction-to-Lead	Steady State	$R_{ ext{ heta}JL}$	16	24	°C/W	

### Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC F	PARAMETERS						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$I_{D}$ =-250µA, $V_{GS}$ = 0V		-30			V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =-30V, V <sub>GS</sub> = 0V				-1	μA
			T <sub>J</sub> = 55°C			-5	
I <sub>GSS</sub>	Gate-Body leakage current	$V_{DS} = 0V, V_{GS} = \pm 16V$				±10	μA
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS} I_D = -250 \mu A$		-0.8	-1.3	-1.6	V
I <sub>D(ON)</sub>	On state drain current	V <sub>GS</sub> =-10V, V <sub>DS</sub> =-5V		-160			A
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =-10V, I <sub>D</sub> =-17A	-		5.5	7	
			T <sub>J</sub> =125°C		7 6.5	8.5	mΩ
			V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-15A			8	
		V <sub>GS</sub> =-4V, I <sub>D</sub> =-13A			6.9	9	
9 <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> =-5V, I <sub>D</sub> =-17A			70		S
V <sub>SD</sub>	Diode Forward Voltage	$I_{S} = -1A, V_{GS} = 0V$			-0.62	-1	V
I <sub>S</sub>	Maximum Body-Diode Continuous Cur			-3	А		
DYNAMIC	C PARAMETERS						
C <sub>iss</sub>	Input Capacitance				4580	5500	pF
C <sub>oss</sub>	Output Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =-15V, f=1MHz			755		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			564		pF	
R <sub>g</sub>	Gate resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1N		160	210	Ω	
SWITCHI	NG PARAMETERS						
Q <sub>g</sub> (-10V)	Total Gate Charge				87	105	nC
Q <sub>g</sub> (-4.5V)	Total Gate Charge	1/1 - 10/(1/1 - 15)/1	I – 17A		41		nC
Q <sub>gs</sub>	Gate Source Charge	V <sub>GS</sub> =-10V, V <sub>DS</sub> =-15V, I <sub>D</sub> =-17A			12.8		nC
Q <sub>gd</sub>	Gate Drain Charge				17		nC
t <sub>D(on)</sub>	Turn-On DelayTime				180		ns
t <sub>r</sub>	Turn-On Rise Time	V <sub>GS</sub> =-10V, V <sub>DS</sub> =15V			260		ns
t <sub>D(off)</sub>	Turn-Off DelayTime	R <sub>L</sub> =-0.9Ω, R <sub>GEN</sub> =3Ω	Γ		1.2		μS
t <sub>f</sub>	Turn-Off Fall Time		ſ		9.7		μS
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =-17A, dl/dt=300A/με	6		32	40	ns
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	e I <sub>F</sub> =-17A, dl/dt=300A/με	3		77		nC

A: The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A = 25^{\circ}$ C. The value in any given application depends on the user's specific board design.

B. The power dissipation P<sub>D</sub> is based on  $T_{J(MAX)}$ =150°C, using  $\leq$  10s junction-to-ambient thermal resistance.

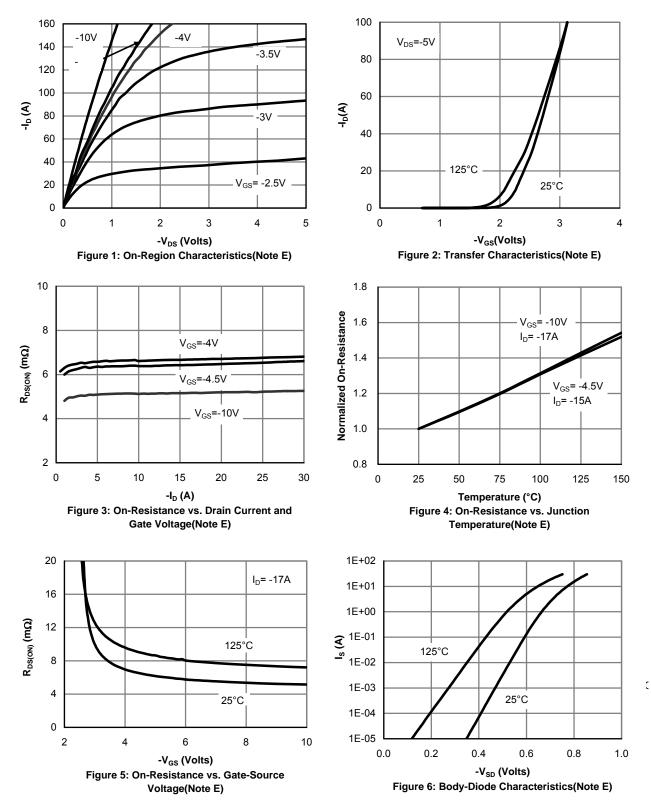
C. Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)}=150$ °C. Ratings are based on low frequency and duty cycles to keep initial  $T_{J}=25$ °C.

D. The  $R_{\rm 6JA}$  is the sum of the thermal impedence from junction to lead  $R_{\rm 6JL}$  and lead to ambient.

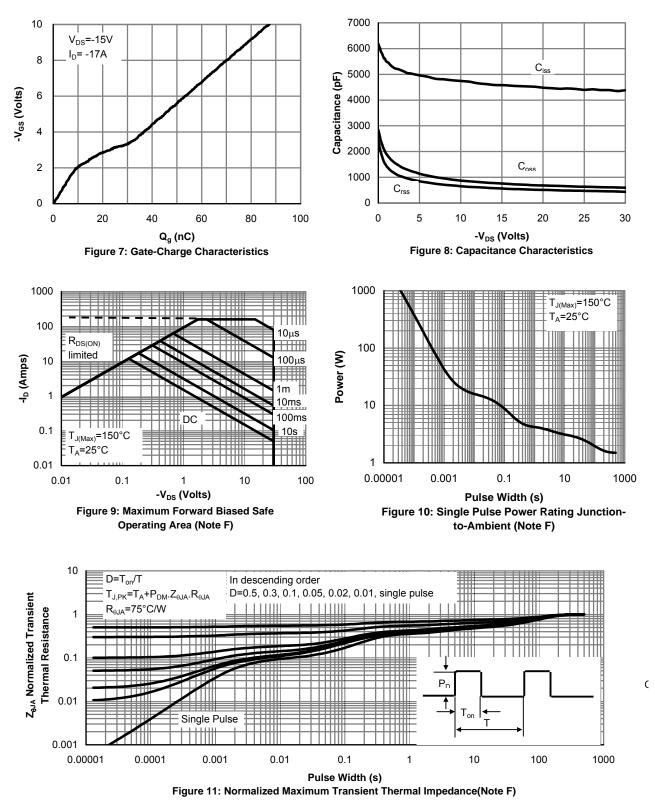
E. The static characteristics in Figures 1 to 6 are obtained using  $<300 \,\mu$ s pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedence which is measured with the device mounted on  $1 \text{ in}^2$  FR-4 board with 2oz. Copper, assuming a maximum junction temperature of  $T_{J(MAX)}$ =150°C. The SOA curve provides a single pulse rating. Rev 0: Aug 2008

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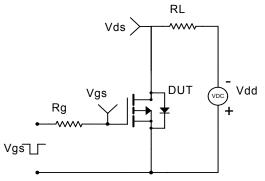
### **TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

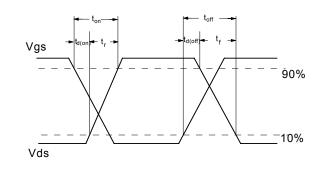


## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

# Gate Charge Test Circuit & Waveform

Resistive Switching Test Circuit & Waveforms





# Diode Recovery Test Circuit & Waveforms

